



Integrated Device Technology, Inc.

### 3.3V CMOS 16-BIT REGISTERED TRANSCEIVER

IDT54/74FCT163952/A/C  
PRODUCT PREVIEW

#### FEATURES:

- 0.5 MICRON CMOS Technology
- **Typical  $t_{sk(o)}$  (Output Skew) < 250ps**
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)
- 25 mil Center SSOP and Cerpack Packages and 19.6 mil pitch TSSOP Package
- Extended commercial range of -40°C to +85°C
- $V_{CC} = 3.3V \pm 0.3V$ , Normal Range or  $V_{CC} = 2.7$  to  $3.6V$ , Extended Range
- CMOS power levels (10 $\mu$ W typ. static)
- Rail-to-Rail output swing for increased noise margin
- Military product compliant to MIL-STD-883, Class B
- Low Ground Bounce (0.3V typ.)
- Inputs (except I/O) can be driven by 3.3V or 5V components

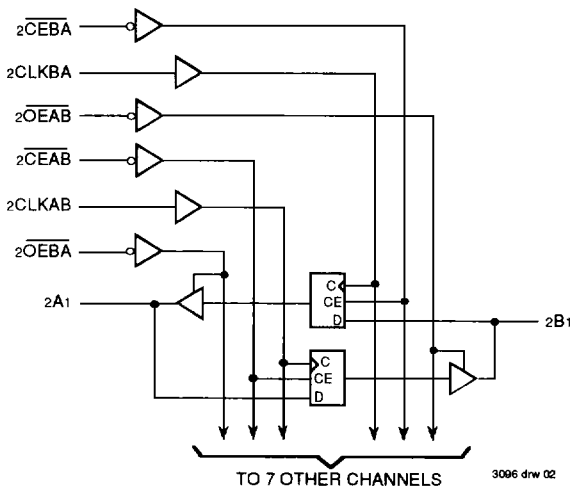
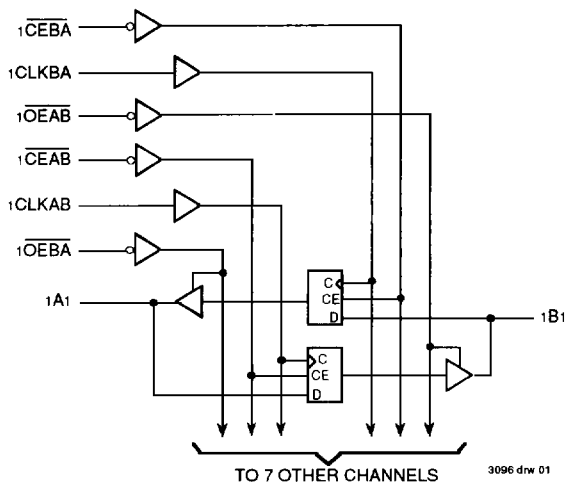
These high-speed, low-power devices are organized as two independent 8-bit D-type registered transceivers with separate input and output control for independent control of data flow in either direction. For example, the A-to-B Enable ( $\overline{xCEAB}$ ) must be LOW to enter data from the A port.  $xCLKAB$  controls the clocking function. When  $xCLKAB$  toggles from LOW-to-HIGH, the data present on the A port will be clocked into the register.  $\overline{xOEAB}$  performs the output enable function on the B port. Data flow from the B port to A port is similar but requires using  $\overline{xCEBA}$ ,  $xCLKBA$ , and  $\overline{xOEBA}$  inputs. Full 16-bit operation is achieved by tying the control pins of the independent transceivers together.

The IDT54/74FCT163952/A/C have series current limiting resistors. These offer low ground bounce, minimal undershoot, and controlled output fall times—reducing the need for external series terminating resistors.

#### DESCRIPTION:

The IDT54/74FCT163952/A/C 16-bit registered transceivers are built using advanced dual metal CMOS technology.

#### FUNCTIONAL BLOCK DIAGRAM



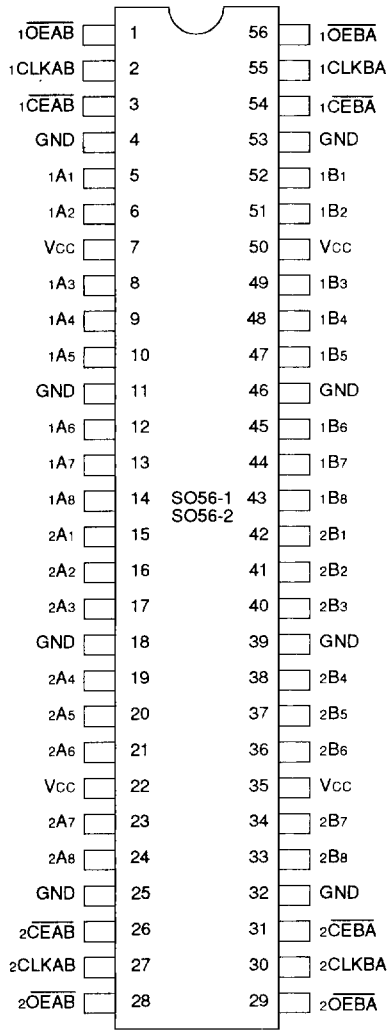
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MILITARY AND COMMERCIAL TEMPERATURE RANGES

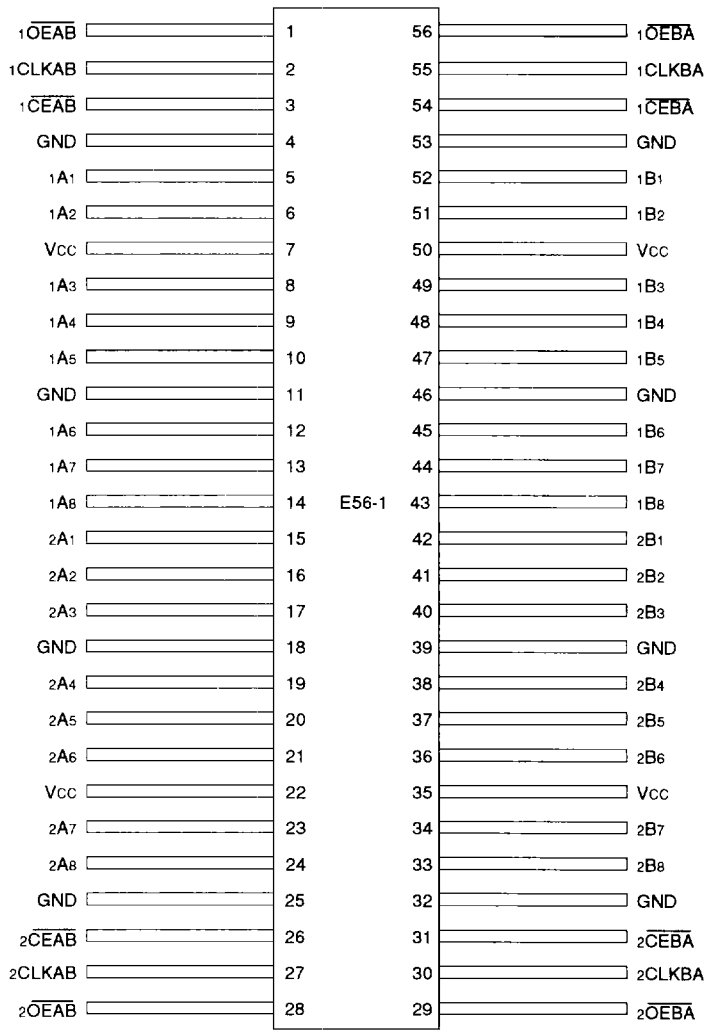
APRIL 1994

**PIN CONFIGURATIONS**



**SSOP  
 TSSOP  
 TOP VIEW**

3096 drw 03



**CERPACK  
 TOP VIEW**

3096 drw 04

**PIN DESCRIPTION**

Pin Names	Description
xOEAB	A-to-B Output Enable Input (Active LOW)
xOEBA	B-to-A Output Enable Input (Active LOW)
xCEAB	A-to-B Clock Enable Input (Active LOW)
xCEBA	B-to-A Clock Enable Input (Active LOW)
xCLKAB	A-to-B Clock Input
xCLKBA	B-to-A Clock Input
xAx	A-to-B Data Inputs or B-to-A 3-State Outputs
xBx	B-to-A Data Inputs or A-to-B 3-State Outputs

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**FUNCTION TABLE<sup>(1,3)</sup>**

Inputs				Outputs
xCEAB	xCLKAB	xOEAB	xAx	xBx
H	X	L	X	B <sup>(2)</sup>
X	L	L	X	B <sup>(2)</sup>
L	↑	L	L	L
L	↑	L	H	H
X	X	H	X	Z

**NOTES:**

- 3096 tbl 02  
A-to-B data flow is shown; B-to-A data flow is similar but uses, xCEBA, xCLKBA, and xOEBA.
- Level of B before the indicated steady-state input conditions were established.
- H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Don't Care  
↑ = LOW-to-HIGH Transition  
Z = High-impedance

**ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

Symbol	Rating	Commercial	Military	Unit
VTERM <sup>(2)</sup>	Terminal Voltage with Respect to GND	-0.5 to +4.6	-0.5 to +4.6	V
VTERM <sup>(3)</sup>	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	V
VTERM <sup>(4)</sup>	Terminal Voltage with Respect to GND	-0.5 to V <sub>CC</sub> + 0.5	-0.5 to V <sub>CC</sub> + 0.5	V
TA	Operating Temperature	-40 to +85	-55 to +125	°C
TBIAS	Temperature Under Bias	-55 to +125	-65 to +135	°C
TSTG	Storage Temperature	-55 to +125	-65 to +150	°C
PT	Power Dissipation	1.0	1.0	W
IOUT	DC Output Current	-60 to +60	-60 to +60	mA

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**NOTES:**

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- V<sub>CC</sub> terminals.
- Input terminals.
- Output and I/O terminals.

**CAPACITANCE (TA = +25°C, f = 1.0MHz)**

Symbol	Parameter <sup>(1)</sup>	Conditions	Typ.	Max.	Unit
CIN	Input Capacitance	V <sub>IN</sub> = 0V	3.5	6.0	pF
CIO	I/O Capacitance	V <sub>OUT</sub> = 0V	3.5	8.0	pF

**NOTE:**

- 3096 lmk 04  
This parameter is measured at characterization but not tested.



### DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Commercial: TA = -40°C to +85°C, VCC = 2.7V to 3.6V; Military: TA = -55°C to +125°C, VCC = 2.7V to 3.6V

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Typ. <sup>(2)</sup>	Max.	Unit
VIH	Input HIGH Level (Input pins)	Guaranteed Logic HIGH Level		2.0	—	5.5	V
	Input HIGH Level (I/O pins)			2.0	—	VCC+0.5	
VIL	Input LOW Level (Input and I/O pins)	Guaranteed Logic LOW Level		-0.5	—	0.8	V
IIH	Input HIGH Current (Input pins) <sup>(6)</sup>	VCC = Max.	VI = 5.5V	—	—	±1	μA
	Input HIGH Current (I/O pins) <sup>(6)</sup>		VI = VCC	—	—	±1	
IIL	Input LOW Current (Input pins) <sup>(6)</sup>		VI = GND	—	—	±1	
	Input LOW Current (I/O pins) <sup>(6)</sup>		VI = GND	—	—	±1	
IOZH	High Impedance Output Current (3-State Output pins) <sup>(6)</sup>	VCC = Max.	VO = VCC	—	—	±1	μA
IOZL			VO = GND	—	—	±1	
VIK	Clamp Diode Voltage	VCC = Min., IIN = -18mA		—	-0.7	-1.2	V
IODH	Output HIGH Current	VCC = 3.3V, VIN = VIH or VIL, VO = 1.5V <sup>(3)</sup>		-36	-60	-110	mA
IODL	Output LOW Current	VCC = 3.3V, VIN = VIH or VIL, VO = 1.5V <sup>(3)</sup>		50	90	200	mA
VOH	Output HIGH Voltage	VCC = Min.	IOH = -0.1mA	VCC-0.2	—	—	V
		VIN = VIH or VIL	IOH = -3mA	2.4	3.0	—	
		VCC = 3.0V VIN = VIH or VIL	IOH = -6mA MIL. IOH = -8mA COM'L.	2.4 <sup>(5)</sup>	3.0	—	
VOL	Output LOW Voltage	VCC = Min.	IOL = 0.1mA	—	—	0.2	V
		VIN = VIH or VIL	IOL = 16mA	—	0.2	0.4	
			IOL = 24mA	—	0.3	0.5	
IOS	Short Circuit Current <sup>(4)</sup>	VCC = Max., VO = GND <sup>(3)</sup>		-60	-135	-240	mA
VH	Input Hysteresis	—		—	150	—	mV
ICCL	Quiescent Power Supply Current	VCC = Max., VIN = GND or VCC	COM'L.	—	0.1	10	μA
ICCH			MIL.	—	0.1	100	
ICCZ				—	0.1	100	

**NOTES:**

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- For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at VCC = 3.3V, +25°C ambient.
- Not more than one output should be tested at one time. Duration of the test should not exceed one second.
- This parameter is guaranteed but not tested.
- VOH = VCC - 0.6V at rated current.
- The test limit for this parameter is ±5μA at TA = -55°C.

**POWER SUPPLY CHARACTERISTICS**

Symbol	Parameter	Test Conditions <sup>(1)</sup>		Min.	Typ. <sup>(2)</sup>	Max.	Unit
$\Delta I_{CC}$	Quiescent Power Supply	$V_{CC} = \text{Max.}$	$V_{IN} = V_{CC} - 0.6V^{(3)}$	—			mA
$I_{CCD}$	Dynamic Power Supply Current <sup>(4)</sup>	$V_{CC} = \text{Max.}$ , Outputs Open $\overline{xOEAB}$ or $\overline{xOEBA} = \text{GND}$ One Input Toggling 50% Duty Cycle	$V_{IN} = V_{CC}$ $V_{IN} = \text{GND}$	—			$\mu A/$ MHz
$I_C$	Total Power Supply Current <sup>(6)</sup>	$V_{CC} = \text{Max.}$ , Outputs Open $f_{CP} = 10\text{MHz}$ (xCLKAB) 50% Duty Cycle $\overline{xOEAB} = \overline{xCEAB} = \text{GND}$ $\overline{xOEBA} = V_{CC}$ One Bit Toggling $f_i = 5\text{MHz}$ 50% Duty Cycle	$V_{IN} = V_{CC}$ $V_{IN} = \text{GND}$	—			mA
			$V_{IN} = V_{CC} - 0.6V$ $V_{IN} = \text{GND}$	—			
		$V_{CC} = \text{Max.}$ , Outputs Open $f_{CP} = 10\text{MHz}$ (xCLKAB) 50% Duty Cycle $\overline{xOEAB} = \overline{xCEAB} = \text{GND}$ $\overline{xOEBA} = V_{CC}$ Sixteen Bits Toggling $f_i = 2.5\text{MHz}$ 50% Duty Cycle	$V_{IN} = V_{CC}$ $V_{IN} = \text{GND}$	—			
$V_{IN} = V_{CC} - 0.6V$ $V_{IN} = \text{GND}$	—						

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**NOTES:**

- For conditions shown as max. or min., use appropriate value specified under Electrical Characteristics for the applicable device type.
- Typical values are at  $V_{CC} = 3.3V$ ,  $+25^\circ\text{C}$  ambient.
- Per TTL driven input; all other inputs at  $V_{CC}$  or  $\text{GND}$ .
- This parameter is not directly testable, but is derived for use in Total Power Supply Calculations.
- Values for these conditions are examples of the  $I_{CC}$  formula. These limits are guaranteed but not tested.
- $I_C = I_{\text{QUIESCENT}} + I_{\text{INPUTS}} + I_{\text{DYNAMIC}}$   
 $I_C = I_{CC} + \Delta I_{CC} D_H N_T + I_{CCD} (f_{CP} N_{CP} / 2 + f_i N_i)$   
 $I_{CC} = \text{Quiescent Current (} I_{CCL}, I_{CCH} \text{ and } I_{CCZ} \text{)}$   
 $\Delta I_{CC} = \text{Power Supply Current for a TTL High Input}$   
 $D_H = \text{Duty Cycle for TTL Inputs High}$   
 $N_T = \text{Number of TTL Inputs at } D_H$   
 $I_{CCD} = \text{Dynamic Current Caused by an Input Transition Pair (HLH or LHL)}$   
 $f_{CP} = \text{Clock Frequency for Register Devices (Zero for Non-Register Devices)}$   
 $N_{CP} = \text{Number of Clock Inputs at } f_{CP}$   
 $f_i = \text{Input Frequency}$   
 $N_i = \text{Number of Inputs at } f_i$

**SWITCHING CHARACTERISTICS OVER OPERATING RANGE**

Symbol	Parameter	Condition <sup>(1)</sup>	FCT163952				FCT163952A				FCT163952C				Unit
			Com'l.		Mil.		Com'l.		Mil.		Com'l.		Mil.		
			Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	Min. <sup>(2)</sup>	Max.	
tPLH	Propagation Delay	CL = 50pF RL = 500Ω					2.0	10.0	2.0	11.0	2.0	6.3	2.0	7.3	ns
tPHL	xCLKAB, xCLKBA to xBx, xAx														
tpZH	Output Enable Time						1.5	10.5	1.5	13.0	1.5	7.0	1.5	8.0	ns
tpZL	xOEBA, xOEB to xAx, xBx														
tPHZ	Output Disable Time						1.5	10.0	1.5	10.0	1.5	6.5	1.5	7.5	ns
tPLZ	xOEBA, xOEB to xAx, xBx														
tsU	Set-up Time HIGH or LOW						2.5	—	2.5	—	2.5	—	2.5	—	ns
	xAx, xBx to xCLKAB, xCLKBA														
tH	Hold Time HIGH or LOW						2.0	—	2.0	—	1.5	—	1.5	—	ns
	xAx, xBx to xCLKAB, xCLKBA														
tsU	Set-up Time HIGH or LOW					3.0	—	3.0	—	3.0	—	3.0	—	ns	
	xOEAB, xOEB to xCLKAB, xCLKBA														
tH	Hold Time HIGH or LOW					2.0	—	2.0	—	2.0	—	2.0	—	ns	
	xOEAB, xOEB to xCLKAB, xCLKBA														
tw	Pulse Width HIGH or LOW					3.0	—	3.0	—	3.0	—	3.0	—	ns	
	xCLKAB or xCLKBA <sup>(4)</sup>														
tsk(o)	Output Skew <sup>(3)</sup>					—	0.5	—	0.5	—	0.5	—	0.5	ns	

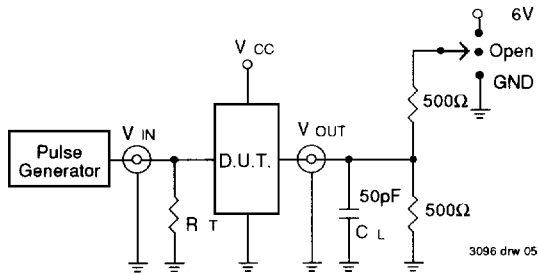
**NOTES:**

1. See test circuits and waveforms.
2. Minimum limits are guaranteed but not tested on Propagation Delays.
3. Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.
4. This parameter is guaranteed but not tested.

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## TEST CIRCUITS AND WAVEFORMS

### TEST CIRCUITS FOR ALL OUTPUTS



### SWITCH POSITION

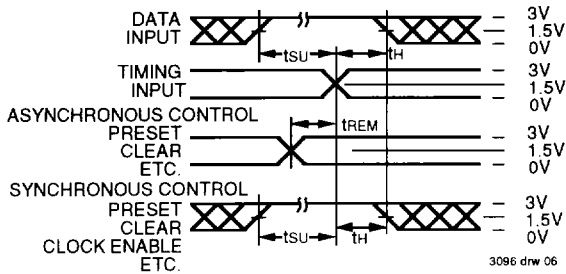
Test	Switch
Open Drain Disable Low Enable Low	6V
Disable High Enable High	GND
All Other tests	Open

#### DEFINITIONS:

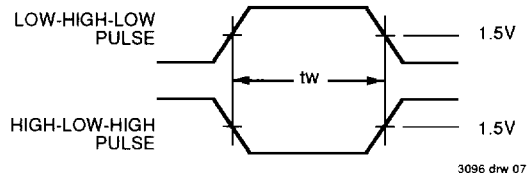
CL = Load capacitance: includes jig and probe capacitance.  
RT = Termination resistance: should be equal to ZOUT of the Pulse Generator.

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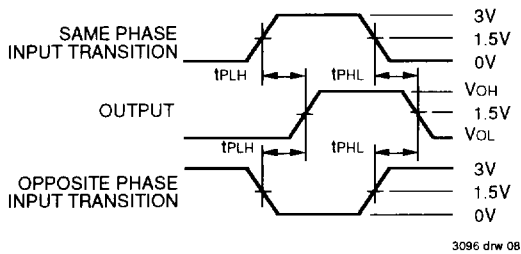
### SET-UP, HOLD AND RELEASE TIMES



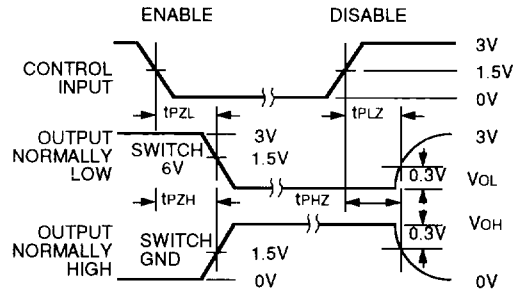
### PULSE WIDTH



### PROPAGATION DELAY



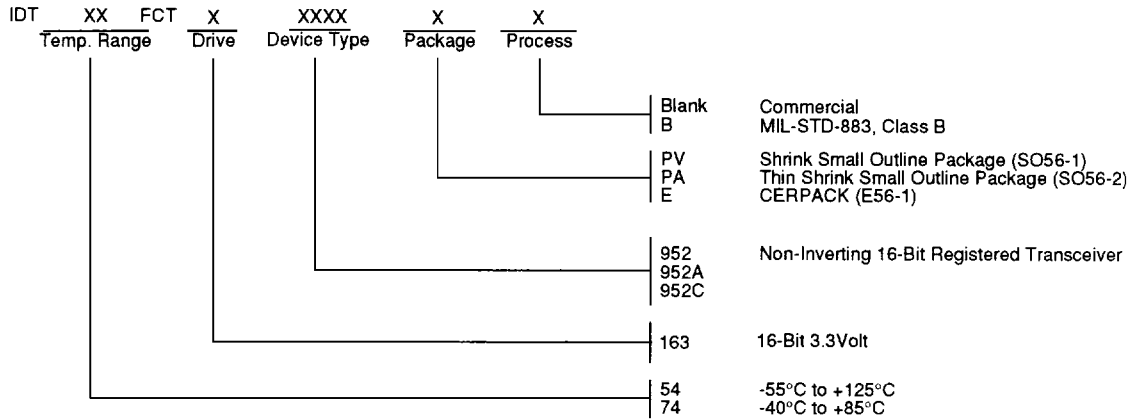
### ENABLE AND DISABLE TIMES



#### NOTES:

1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.
2. Pulse Generator for All Pulses: Rate  $\leq$  1.0MHz;  $t_f \leq$  2.5ns;  $t_r \leq$  2.5ns.
3. If Vcc is below 3V, input voltage swings should be adjusted not to exceed Vcc.

**ORDERING INFORMATION**



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